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Notice of Allowability	Application No.	Applicant(s)	
	10/812,328	BELYANIN ET AL.	
	Examiner	Art Unit	
	John D. Lee	2874	

-- **The MAILING DATE of this communication appears on the cover sheet with the correspondence address--**

All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTO-85) or other appropriate communication will be mailed in due course. **THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS.** This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.

1. This communication is responsive to _____.
2. The allowed claim(s) is/are 1-16.
3. The drawings filed on 29 March 2004 are accepted by the Examiner.
4. Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
 - a) All b) Some* c) None of the:
 1. Certified copies of the priority documents have been received.
 2. Certified copies of the priority documents have been received in Application No. _____.
 3. Copies of the certified copies of the priority documents have been received in this national stage application from the International Bureau (PCT Rule 17.2(a)).

* Certified copies not received: _____.

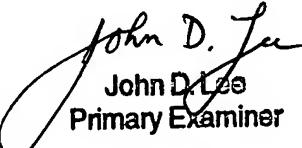
Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application.

THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.

5. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient.
6. CORRECTED DRAWINGS (as "replacement sheets") must be submitted.
 - (a) including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached
 - 1) hereto or 2) to Paper No./Mail Date _____.
 - (b) including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date _____.
- Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d).
7. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.

Attachment(s)

1. Notice of References Cited (PTO-892)
2. Notice of Draftsperson's Patent Drawing Review (PTO-948)
3. Information Disclosure Statements (PTO-1449 or PTO/SB/08),
Paper No./Mail Date 0304
4. Examiner's Comment Regarding Requirement for Deposit
of Biological Material
5. Notice of Informal Patent Application (PTO-152)
6. Interview Summary (PTO-413),
Paper No./Mail Date _____.
7. Examiner's Amendment/Comment
8. Examiner's Statement of Reasons for Allowance
9. Other _____.


John D. Lee
Primary Examiner

EXAMINER'S STATEMENT OF REASONS FOR ALLOWANCE

The following is an Examiner's Statement of Reasons for Allowance: The prior art fails to disclose or reasonably suggest a monolithically integrated waveguide-based intersubband (ISB) nonlinear optical device (or quantum cascade nonlinear optical device) of the type claimed, wherein the waveguide includes a nonlinear mixing region and a core region, the core region includes an active region with a plurality of repeat units, and with each repeat unit including a unipolar radiative transition (RT) region and a relaxation/injection (I/R) region. The RT regions generate laser light (via intersubband optical transitions) at a first center frequency, and the nonlinear mixing region generates parametric light (in response to the generated laser light) at a second center frequency different from the first center frequency. The prior art also fails to disclose or suggest such a waveguide-based device wherein the laser light is generated in a first transverse mode while the parametric light is generated in a second different transverse mode, wherein effective-refractive-index versus ridge-width characteristics of the first and second modes intersect one another at a phase matching width, and wherein such phase matching width is equal to the ridge width of the waveguide. Claims 1-16 herein are therefore allowed.

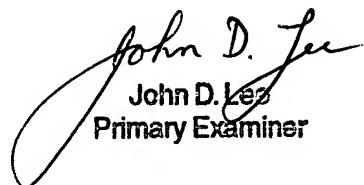
Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

DISCUSSION OF THE CITED PRIOR ART

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. U.S. Patent 6,795,467 to Capasso et al describes a waveguide-based intersubband (ISB), quantum cascade nonlinear optical laser device, but the device does not include all the waveguide regions and specific characteristics of the claimed device (refer to the immediately preceding paragraph).

All of the prior art documents submitted by applicant in the Information Disclosure Statement filed on March 29, 2004, have been considered and made of record. Note the attached initialed copy of form PTO-1449. None of these documents discloses or suggests a device having the specific limitations described above.

Any inquiry concerning the merits of this communication should be directed to Examiner John D. Lee at telephone number (571) 272-2351. The Examiner's normal work schedule is Tuesday through Friday, 6:30 AM to 5:00 PM. Any inquiry of a general or clerical nature (i.e. a request for a missing form or paper, etc.) should be directed to the Technology Center 2800 receptionist at telephone number (571) 272-1562, to the technical support staff supervisor (Team 8) at telephone number (571) 272-1564, or to the Technology Center 2800 Customer Service Office at telephone number (571) 272-1626.



John D. Lee
John D. Lee
Primary Examiner